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# Errata to IEEE Standard for the Preparation of Test Procedures for the Thermal Evaluation of Solid Electrical Insulating Materials

Sponsor

**Standards Coordinating Committee 4 on Thermal Rating**

of the

**IEEE Electrical Insulation Society**

*Correction Sheet*

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**Page 15, NOTE 2 to Table B.1—Suggested exposure temperatures and times, should be changed to read as follows:**

2—When extending the test program by submitting additional specimens to aging at temperatures below the lower of the originally planned aging temperatures, a temperature interval of 10 °C and a cycle duration of 42 days for TI/RTI determination should be considered.